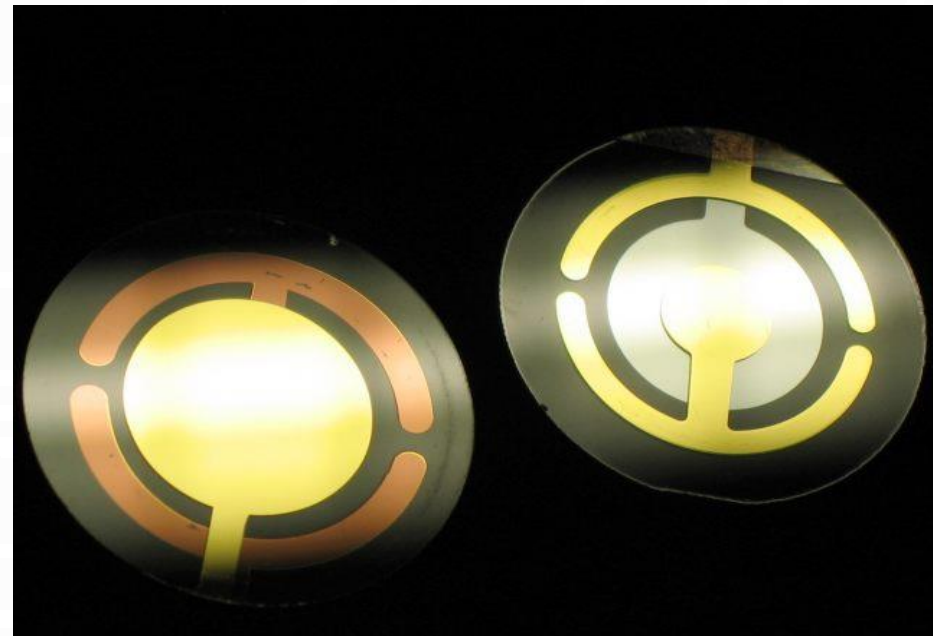


HOW IT WORKS: QUARTZ CRYSTAL MICROBALANCE (QCM)

JACOB GRANT

SHAW GROUP MEETING

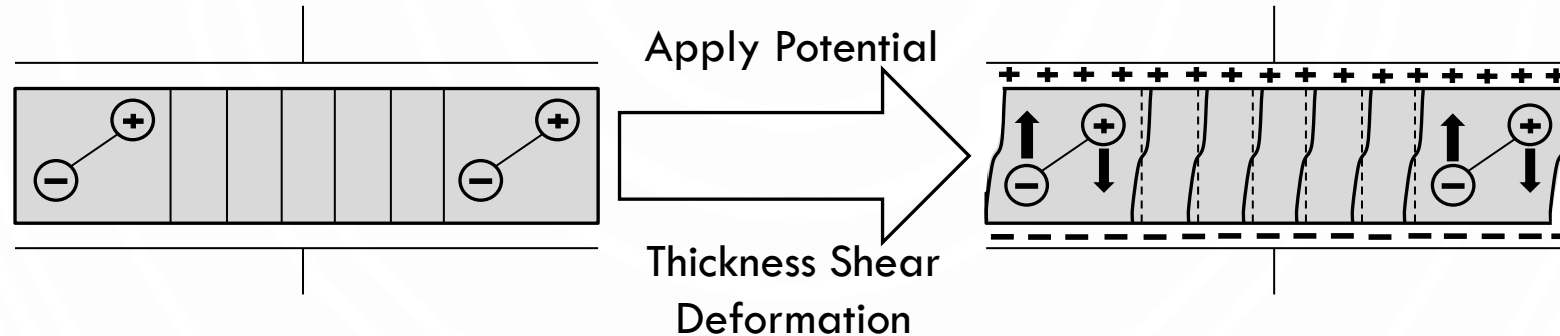
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THEORY

- Piezoelectric material – Electric field forms in the presence of mechanical stress and vice versa (converse piezoelectric effect)

Examples: Quartz crystals, sucrose, DNA, silk, tendon



- Alternating the potential (sine wave) causes the crystal to oscillate
- With a properly cut crystal and an appropriate alternating potential, a standing shear wave is formed at the resonant frequency of quartz:

$$f_0 = \frac{\sqrt{\mu_q}}{2t_q}; \mu_q = 2.947 \times 10^{11} \frac{g}{cm * s^2}, \rho_q = 2.648 \frac{g}{cm^3}, t_q = \text{crystal thickness}$$

$$\text{Quality (Q) Factor} = \frac{\text{frequency}}{\text{bandwidth}} = \frac{f_c}{\Delta f_{FWHM}}; Q \cong 10^6$$

Basics of a Quartz Crystal Microbalance. Gamry. www.gamry.com (accessed 3/28/14).

Deakin, M.R.; Buttry, D.A. *Anal. Chem.* **1989**, 61(20), 1147-1154.

APPLICATIONS TO SURFACE SCIENCE

- Resonant frequency of quartz can be precisely determined
- Small amounts of matter (ng/cm^2) placed on the crystal surface can be quantified by measuring the change in resonating frequency (Sauerbrey equation)

$$\Delta f = -\frac{2nf_0^2}{\sqrt{\rho_q\mu_q}} \frac{\Delta m}{A}; T_f = \frac{\Delta m}{A\rho_f}$$

- Assumes the deposited film is uniform and rigid (and $\Delta f/f < 2\%$)
- If $\Delta f/f > 2\%$, Sauerbrey eqn. is expanded to incorporate film elasticity
- Can be applied to liquid contact measurements

$$\Delta f = -f_0^{3/2} \sqrt{\frac{\eta_l\rho_l}{\pi\rho_q\mu_q}}$$

ELECTROCHEMICAL QCM (EQCM)

- Integrated QCM and potentiostat
- Impedance and mass analysis
- Mass change versus time, charge, potential
- Using EQCM, the current efficiency (ratio of mass deposited at the electrode surface during an electrochemical reaction to the total charge passed through the electrode) can be determined
- Applications in electrodeposition, corrosion studies, self-assembled monolayers



QCM WITH DISSIPATION MONITORING (QCM-D)

- Provides structural (viscoelastic) thin film analysis as well as mass analysis
- Dissipation (damping) is significant when the adsorbed film is not rigid (i.e. film and crystal oscillations not fully coupled)

$$D = \frac{E_{lost}}{2\pi E_{stored}}$$

- The potential is shut off, and the time required for oscillation to cease quantifies the “softness” (viscoelasticity) of the adsorbed film
- Visualization

